Application/Control No. Applicant(s)/Patent Under Reexamination 10/677,257 INOUE, SATOSHI Notice of References Cited Examiner Art Unit Page 1 of 1 2822 Michael Trinh **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-5,830,787 11-1998 Α Kim, Hong Seuk 438/163 US-5,569,935 10-1996 Takemura et al. 257/51 В С US-D US-Ε US-F US-G US-Н US-1 US-J Κ US-US-US-М FOREIGN PATENT DOCUMENTS . Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Ţ **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧

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